## **Freescale Semiconductor**

Technical Data

**RF Power LDMOS Transistor** 

## N-Channel Enhancement-Mode Lateral MOSFET

RF power transistor designed for pulse applications operating at frequencies between 960 and 1400 MHz, 1% to 20% duty cycle. This device is suitable for aerospace and defense applications such as DME, IFF, and L-band radar.

• Typical Pulse Performance:  $V_{DD}$  = 50 Vdc,  $I_{DQ}$  = 10 mA,  $P_{out}$  = 10 W Peak (2 W Avg.), f = 1090 MHz, Pulse Width = 100  $\mu$ sec, Duty Cycle = 20% Power Gain — 25 dB Drain Efficiency — 69%

#### **Features**

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Qualified Up to a Maximum of 50 V<sub>DD</sub> Operation
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- In Tape and Reel. R4 Suffix = 100 Units, 16 mm Tape Width, 7-inch Reel.

Document Number: MMRF1019N

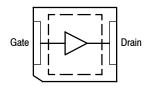
Rev. 0, 7/2014

**VRoHS** 

# **MMRF1019NR4**

1090 MHz, 10 W, 50 V PULSE RF POWER LDMOS TRANSISTOR





Note: The center pad on the backside of the package is the source terminal for the transistor.

**Figure 1. Pin Connections** 

### **Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-0.5, +100	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Case Operating Temperature	T <sub>C</sub>	150	°C
Operating Junction Temperature	TJ	200	°C

## **Table 2. Thermal Characteristics**

Characteristic	Symbol	Value <sup>(1,2)</sup>	Unit
Thermal Resistance, Junction to Case Case Temperature 79°C, 10 W Peak, 100 μsec Pulse Width, 20% Duty Cycle	$Z_{\theta JC}$	1.6	°C/W

- 1. MTTF calculator available at <a href="http://www.freescale.com/rf">http://www.freescale.com/rf</a>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
- 2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <a href="http://www.freescale.com/rf">http://www.freescale.com/rf</a>. Select Documentation/Application Notes AN1955.



## **Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	1C
Machine Model (per EIA/JESD22-A115)	А
Charge Device Model (per JESD22-C101)	IV

## **Table 4. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

## **Table 5. Electrical Characteristics** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics			•	•	•
Gate-Source Leakage Current (V <sub>GS</sub> = 5 Vdc, V <sub>DS</sub> = 0 Vdc)	I <sub>GSS</sub>	_	_	10	μAdc
Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 7 mA)	V <sub>(BR)DSS</sub>	110	_	_	Vdc
Zero Gate Voltage Drain Leakage Current (V <sub>DS</sub> = 50 Vdc, V <sub>GS</sub> = 0 Vdc)	I <sub>DSS</sub>	_	_	50	μAdc
Zero Gate Voltage Drain Leakage Current (V <sub>DS</sub> = 100 Vdc, V <sub>GS</sub> = 0 Vdc)	I <sub>DSS</sub>	_	_	2.5	mA
On Characteristics	<u> </u>				_
Gate Threshold Voltage (V <sub>DS</sub> = 10 Vdc, I <sub>D</sub> = 36 μAdc)	V <sub>GS(th)</sub>	1	1.7	2.5	Vdc
Gate Quiescent Voltage (V <sub>DD</sub> = 50 Vdc, I <sub>D</sub> = 10 mAdc, Measured in Functional Test)	V <sub>GS(Q)</sub>	1.7	2.4	3.2	Vdc
Drain-Source On-Voltage (V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 70 mAdc)	V <sub>DS(on)</sub>	_	0.2	_	Vdc
Dynamic Characteristics			•	•	•
Reverse Transfer Capacitance (V <sub>DS</sub> = 50 Vdc ± 30 mV(rms)ac @ 1 MHz, V <sub>GS</sub> = 0 Vdc)	C <sub>rss</sub>	_	0.1	_	pF
Output Capacitance (V <sub>DS</sub> = 50 Vdc ± 30 mV(rms)ac @ 1 MHz, V <sub>GS</sub> = 0 Vdc)	C <sub>oss</sub>	_	3.38	_	pF
Input Capacitance (V <sub>DS</sub> = 50 Vdc, V <sub>GS</sub> = 0 Vdc ± 30 mV(rms)ac @ 1 MHz)	C <sub>iss</sub>	_	9.55	_	pF

Functional Tests (In Freescale Test Fixture, 50 ohm system)  $V_{DD}$  = 50 Vdc,  $I_{DQ}$  = 10 mA,  $P_{out}$  = 10 W Peak (2 W Avg.), f = 1090 MHz, 100 µsec Pulse Width, 20% Duty Cycle

Power Gain	G <sub>ps</sub>	23	25	28	dB
Drain Efficiency	$\eta_{D}$	66	69	_	%
Input Return Loss	IRL	_	-12	-8	dB

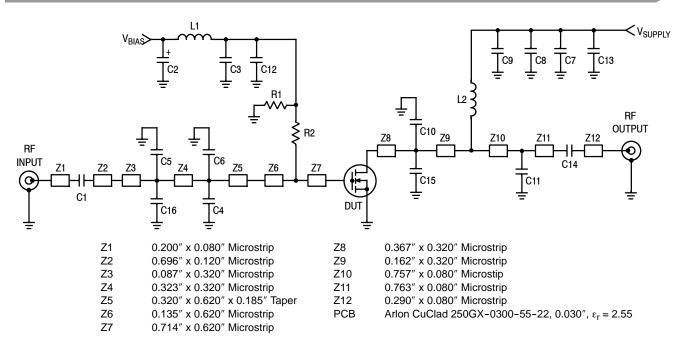


Figure 2. MMRF1019NR4 Test Circuit Schematic

Table 6. MMRF1019NR4 Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C9, C12	43 pF Chip Capacitors	ATC100B430JT500XT	ATC
C2	10 μF, 35 V Tantalum Capacitor	T491D106K035AT	Kemet
C3, C8	2.2 μF, 100 V Chip Capacitors	GQM1885C2A2R2CB01B	Murata
C4, C6	7.5 pF Chip Capacitors	ATC100B7R5CT500XT	ATC
C5, C16	3.0 pF Chip Capacitors	ATC100B3R0CT500XT	ATC
C7	0.1 μF Chip Capacitor	C1206C104K5RACTR	Kemet
C10, C15	0.3 pF Chip Capacitors	ATC100B0R3BT500XT	ATC
C11	5.6 pF Chip Capacitor	ATC100B5R6CT500XT	ATC
C13	470 μF, 63 V Chip Capacitor	477KXM063M	Illlinois Capacitor
C14	47 pF Chip Capacitor	ATC100B470JT500XT	ATC
L1	8 nH Inductor	A03TKLC	Coilcraft
L2	5 nH Inductor	A02TKLC	Coilcraft
R1	3300 Ω, 1/4 W Chip Resistor	CRCW12063301FKEA	Vishay
R2	10 Ω, 1/4 W Chip Resistor	CRCW120610R0FKEA	Vishay

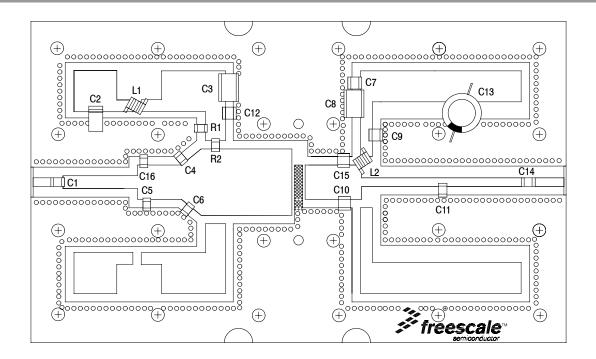


Figure 3. MMRF1019NR4 Test Circuit Component Layout

### TYPICAL CHARACTERISTICS

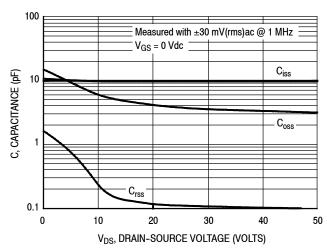


Figure 4. Capacitance versus Drain-Source Voltage

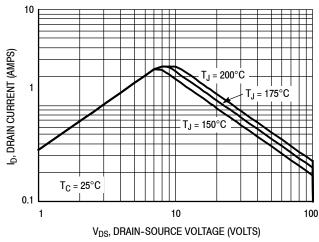


Figure 5. DC Safe Operating Area

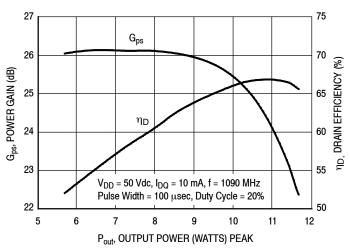


Figure 6. Power Gain and Drain Efficiency versus Output Power

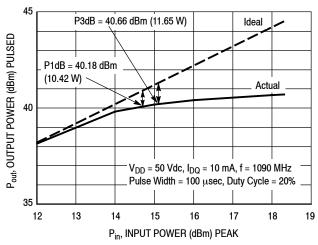


Figure 7. Output Power versus Input Power

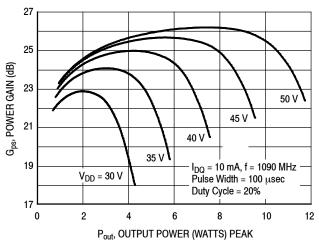


Figure 8. Power Gain versus Output Power

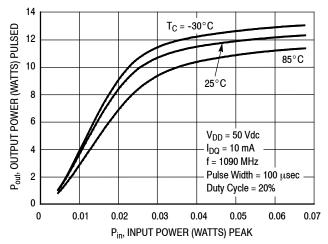


Figure 9. Output Power versus Input Power

### **TYPICAL CHARACTERISTICS**

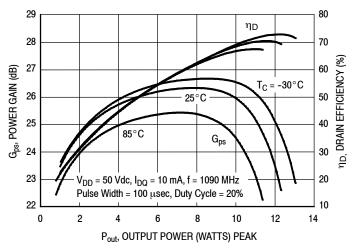
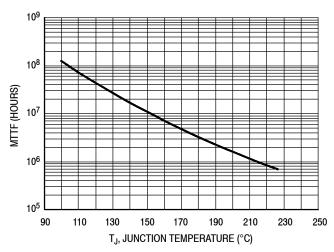


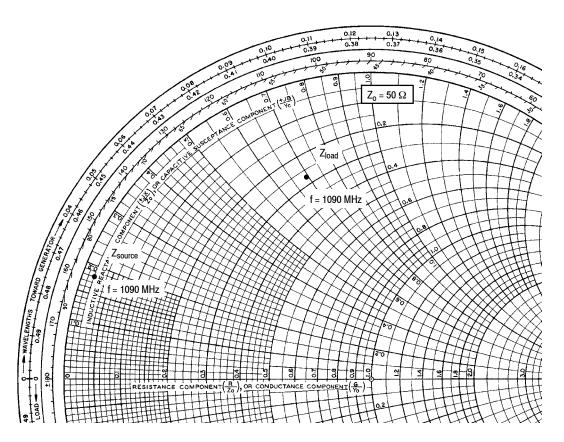
Figure 10. Power Gain and Drain Efficiency versus
Output Power



This above graph displays calculated MTTF in hours when the device is operated at V<sub>DD</sub> = 50 Vdc, P<sub>out</sub> = 10 W Peak, Pulse Width = 100  $\mu sec$ , Duty Cycle = 20%, and  $\eta_D$  = 69%.

MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Figure 11. MTTF versus Junction Temperature



 $V_{DD}$  = 50 Vdc,  $I_{DQ}$  = 10 mA,  $P_{out}$  = 10 W Peak

f MHz	$Z_{source} \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ $	Z <sub>load</sub> Ω
1090	1.15 + j8.96	13.47 + j34.32

Z<sub>source</sub> = Test circuit impedance as measured from gate to ground.

 $Z_{load}$  = Test circuit impedance as measured from drain to ground.

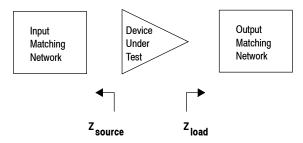


Figure 12. Series Equivalent Source and Load Impedance

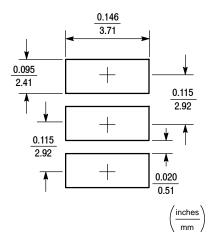


Figure 13. Solder Footprint for PLD-1.5

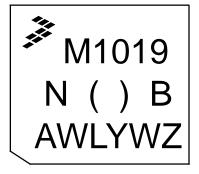
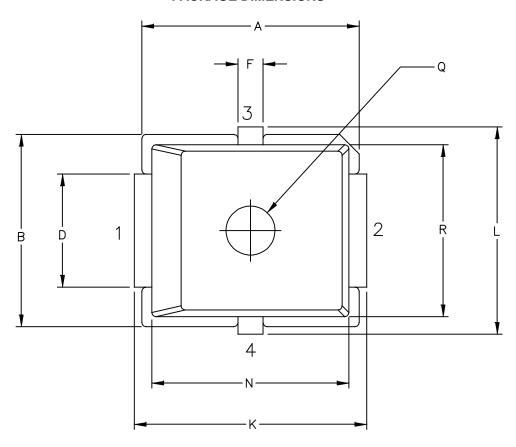
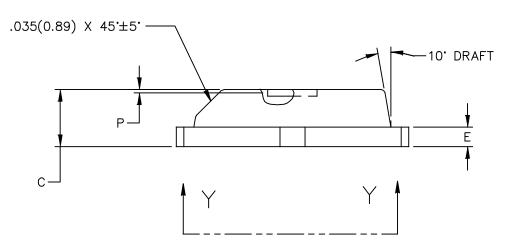


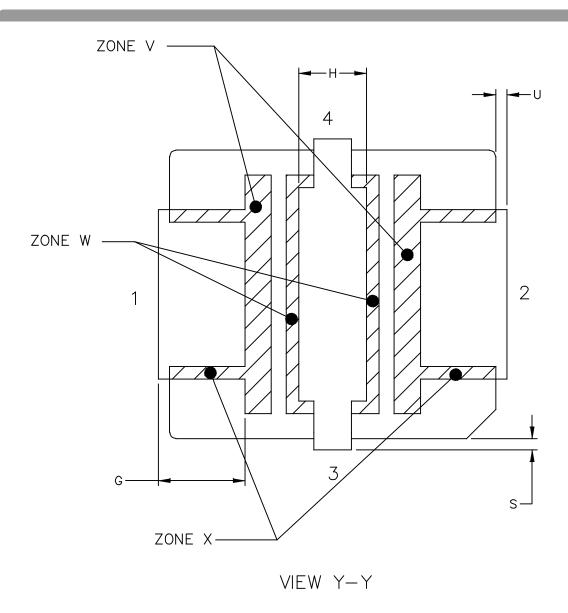
Figure 14. Product Marking

## PACKAGE DIMENSIONS





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PLD-1.5		CASE NUMBER	R: 466–03	31 MAR 2005
		STANDARD: NO	DN-JEDEC	

## NOTES:

- 1. CONTROLLING DIMENSION: INCH
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. RESIN BLEED/FLASH ALLOWABE IN ZONES V, W AND X.

### STYLE 1:

PIN 1 - DRAIN PIN 2 - GATE PIN 3 - SOURCE PIN 4 - SOURCE

	IN	CH	MIL	LIMETER			INCH	М	ILLIMETER
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.255	.265	6.48	6.73	Q	.055	.063	1.40	1.60
В	.225	.235	5.72	5.97	R	.200	.210	5.08	5.33
c	.065	.072	1.65	1.83	s	.006	.012	0.15	0.31
D	.130	.150	3.30	3.81	U	.006	.012	0.15	0.31
E	.021	.026	0.53	0.66	ZONE V	.000	.021	0.00	0.53
F	.026	.044	0.66	1.12	ZONE W	.000	.010	0.00	0.25
G	.050	.070	1.27	1.78	ZONE X	.000	.010	0.00	0.25
н	.045	.063	1.14	1.60					
J	.160	.180	4.06	4.57					
K	.273	.285	6.93	7.24					
L	.245	.255	6.22	6.48					
N	.230	.240	5.84	6.10					
Р	.000	.008	0.00	0.20					
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### PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

## **Application Notes**

• AN1955: Thermal Measurement Methodology of RF Power Amplifiers

## **Engineering Bulletins**

• EB212: Using Data Sheet Impedances for RF LDMOS Devices

## **Software**

• Electromigration MTTF Calculator

For Software, do a Part Number search at http://www.freescale.com, and select the "Part Number" link. Go to the Software & Tools tab on the part's Product Summary page to download the respective tool.

### **REVISION HISTORY**

The following table summarizes revisions to this document.

Revision	Date	Description
0	July 2014	Initial Release of Data Sheet

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